

Notice of References Cited	Application/Control No. 10/532,685	Applicant(s)/Patent Under Reexamination SAITOH, TAKASHI	
	Examiner TRI V. NGUYEN	Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0077515	04-2003	Chen et al.	429/231.8
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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